## Notice of References Cited Application/Control No. 10/520,291 Examiner Rel-TSANG SHIAO Applicant(s)/Patent Under Reexamination PARK ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	Α	US-			
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	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U	An et al., Journal of the American Chemical society, 2004, 126:10232-10233.		
	V			
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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